

<b>Notice of References Cited</b>	Application/Control No. 10/535,313		Applicant(s)/Patent Under Reexamination SAKURAI ET AL.	
	Examiner Thong Q. Nguyen		Art Unit 2872	Page 1 of 1

#### U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,269,227	07-2001	Hamasaki et al.	396/534
*	B	US-5,294,954	03-1994	Nomura et al.	396/448
*	C	US-5,126,881	06-1992	Crema, Rolf	359/611
*	D	US-5,255,120	10-1993	Anzai et al.	359/511
*	E	US-4,909,617	03-1990	Boyd, Jeffrey M.	359/511
*	F	US-2,291,821	08-1942	MCNABB JOSEPH H	359/511
*	G	US-3,614,196	10-1971	Schlapp, Werner	359/611
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

#### FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	6-51386	02-1994	Japan	Yoshida Daisuke	359/611
	O	2000-180918	06-2000	Japan	Tsuchida Yoshihisa	359/611
	P					
	Q					
	R					
	S					
	T					

#### NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	English translation of the Japanese reference No. 6-51386
	V	English translation of the Japanese reference No. 2000-180918
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.